

Irradiation of powered AtlasPix3.1 at Bonn Cyclotron

Maja Lecher

08.04.2022

Goal

- Dates: 18.-21.07.2022
- Irradiate HV-biased AtlasPix3.1 at Bonn HSKP Cyclotron facility
 - Available proton energies: 7 - 14 MeV
 - Applied irradiation currents: 20 - 60 nA
- Characterize chip before & after, take IV curves in between irradiation steps
- Study TID + bulk damage

Setup

Beam area

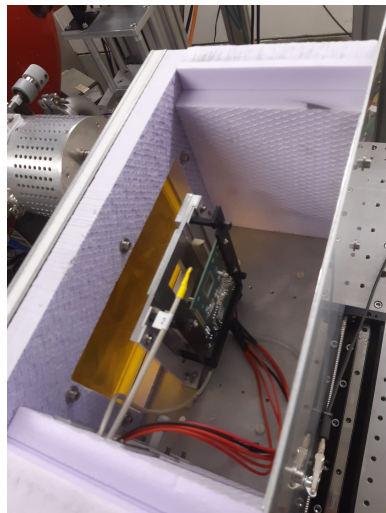
- Cooling box w Kapton foil entry housing DUT
 - Cooling via N_2 ($T \sim -15^\circ C$)
 - 2 temperature sensors
- DUT: AtlasPix3.1 powered via PCIe adapter and connected to PS's via long BNC cables (Supplied LV's: V_{ssa} , V_{dd} , V_{min} , gate)



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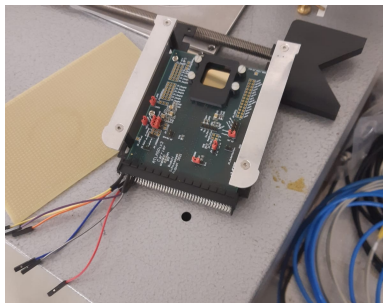
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Setup

Gallery

- Power supplies connected to DUT via BNC cables
 - 2 HAMEC LV supplies for V_{dd} , V_{ssa} , V_{min} , gate
 - 1 Keithley 2611b for HV
- Lab PC with slow control software
- Full GECCO + FPGA setup for data taking before/after irradiation

Control room

- 2nd PC connected to lab PC via local network → manage slow control system from here



Procedure

- Pre-irrad characterization
 - IV curve → Breakdown voltage, leakage current
 - Fe55 spectrum → ToT
 - SCurves → Monitor threshold changes
- Irradiation
 - 5-10 fast scans at increasing bias voltages
 - Scanning speed: 60 mm/s
 - Irrad current: 40 nA
 - Bias voltages: 0 - 60 V, 10 V steps
 - Total dose: $1.9\text{e}13 \text{ protons/cm}^2 \approx 7.8\text{e}13 \text{ n}_{\text{eq}}/\text{cm}^2$
 - IV curve after each voltage step
 - Slow scans at 60 V bias voltage & decreasing irradi. currents
 - Scanning speed: 12 mm/s
 - Irrad. currents: 40 nA, 30 nA, 20 nA
 - IV curve after last irradiation

→ Total fluence after irradi.: $1.05\text{e}14 \text{ n}_{\text{eq}}/\text{cm}^2$; compare LHCb expectation: $5.9\text{e}14 \text{ n}_{\text{eq}}/\text{cm}^2$

Procedure

- Post-irrad. characterization (To Do)
 - Original intention: Fe scan before leaving, but: could not get chip back up and running properly after irrad.
 - Chip configurable (but needs re-tuning)
 - Leakage currents high ($\sim 500\mu\text{A}$)
 - Injections not working at all
 - Chip very noisy without cooling, some decoding errors pre-tuning
 - FPGA unhappy when cooled (commercial FPGA, specified for 0-85 °C op. temp.)
 - Plan: attempt to revive chip; if successful: Fe55 spectrum, SCurves

Irradiation protocol

Fast scan (60 mm/s):

V_{bias} during irradi. [V]	Total fluence [neq/cm ²]	I_{proton} [nA]
0	5.11e12	40 nA
0	1.14e13	40 nA
-10	2.32e13	40 nA
(failure; 0 V & LV off)	3.16e13	40 nA
-30	4.00e13	40 nA
-40	4.76e13	40 nA
-50	6.11e13	40 nA
-60	7.8e13	40 nA

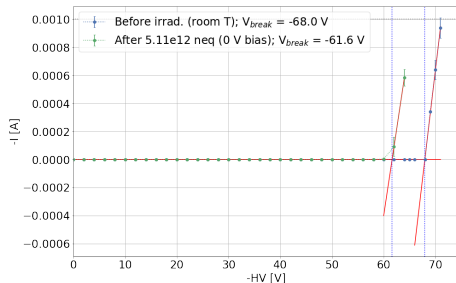
Slow scan (12 mm/s):

V_{bias} during irradi. [V]	Total fluence [neq/cm ²]	I_{proton} [nA]
-60	Unknown	40 nA
-60	Unknown	30 nA
-60	1.05e14	20 nA

IV curves

Breakdown voltage (Note: current limit set too low)

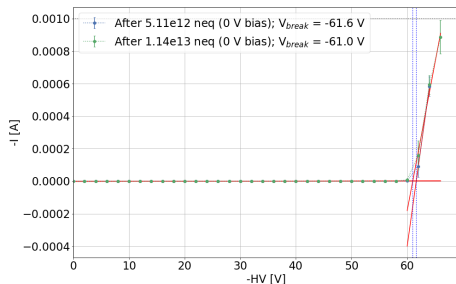
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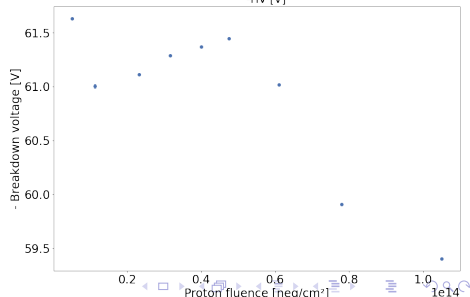
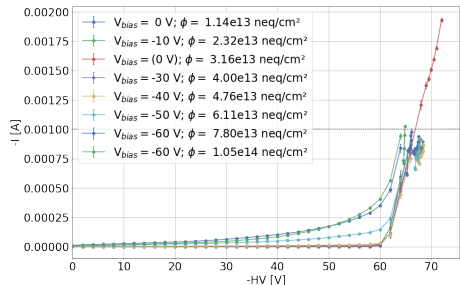
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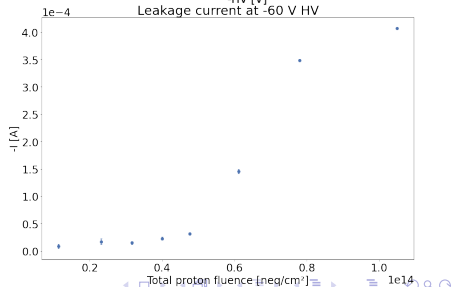
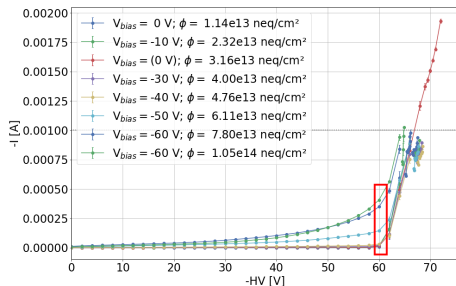
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- Between irradiation steps up to $4.76\text{e}13 \text{ neq/cm}^2$: Slight increase in V_{break} ; after: drop (note: better fit model necessary?)



IV curves

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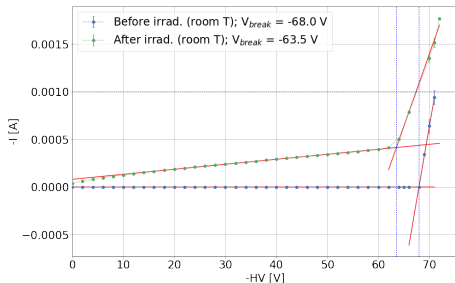
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- Steep increase in leakage current during IV's after 4.76×10^{13} neq/cm²



IV curves

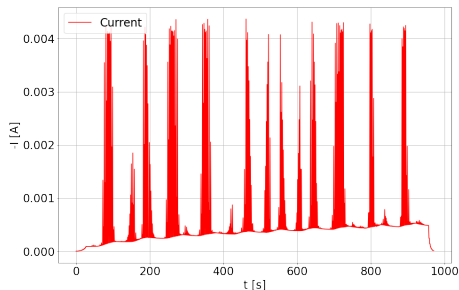
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- Day after irradi. at room T: $V_{\text{break}} \sim -63.5$ V \rightarrow Shift in breakdown voltage partially reversed



Leakage current during irradiation

- Proton spill structure clearly visible in leakage current
- Expected beam-induced current for 40 nA proton current, 100 μm depletion zone: 7 mA $\Rightarrow \sim$ 4 mA leakage current during spills (seen for all bias steps) plausible
- Leakage current between spills: from lower envelope \Rightarrow steady increase



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Answer: The rate R of protons is equal to

$$R = \frac{I}{q_e}$$

The energy deposited per proton is

$$E = \frac{\Delta E}{\Delta X} \cdot \rho_{Si} \cdot d = 29 \text{ MeV cm}^{-2} \text{ g}^{-1} \cdot 2.31 \frac{\text{g}}{\text{cm}^3} \cdot 100 \mu\text{m} = 6.7 \cdot 10^5 \text{ eV}$$

The number of electrons produced by one proton is

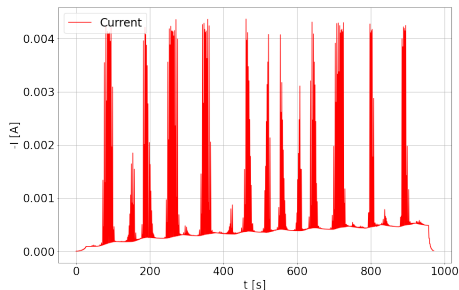
$$N_e = \frac{E}{3.65} = \frac{6.7 \cdot 10^5 \text{ eV}}{3.65 \text{ eV}} = 1.8 \cdot 10^5$$

Combining all that gives

$$I_{\text{leak}} = q_e N_e \cdot R = N_e \cdot I = 1.8 \cdot 10^5 \cdot 40 \text{ nA} = 7.2 \text{ mA}$$

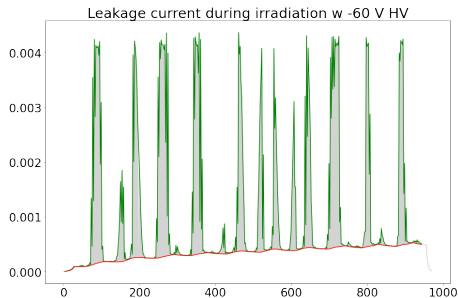
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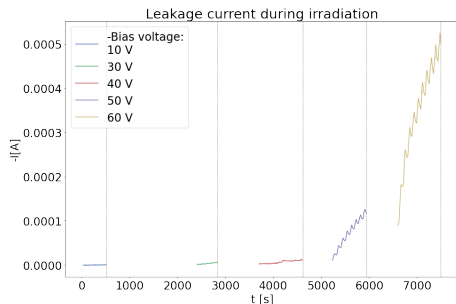
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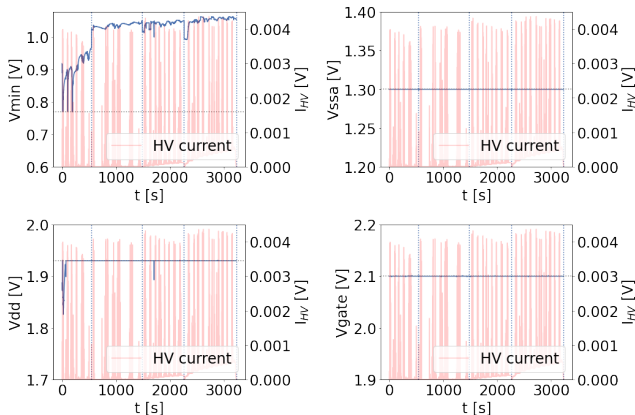


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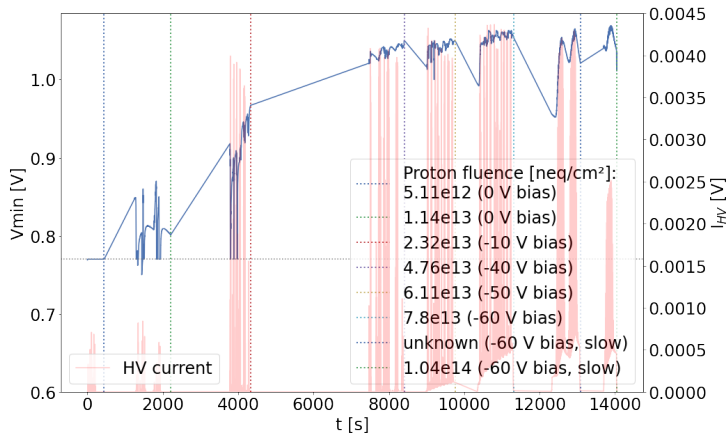
LV behaviour (Voltages)



LV voltages at -10, -40, -50, and -60 V bias voltage during irradiation

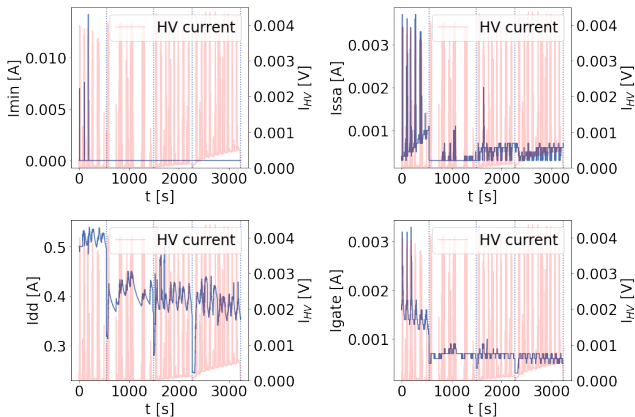
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LV behaviour (Currents)



LV currents at -10, -40, -50, and -60 V bias voltage during irradiation; Note: -20, -30 V missing

→ Proton spill structure visible in I_{dd} , I_{ssa} , and gate; not in I_{min}

To Do

- New IV's with returned chip (incl. scans in climate chamber)
- Incorporate temperature & fluence data from irradi_control
- Analyze slow scans
- New irradi. campaign in Bonn?